VALVE ELECTRONIC CV2435

Specification MOS/CV2435 Issue 2 dated: - 25th January 1959. To be read in conjunction with K1001 and BS448 Security Specification Valve Unclassified Unclassified

← Indicates a change

TYPE OF VALVE:- TYPE OF DEFLECTION:- TYPE OF FOCUS:- EULB:- SCREEN:- PROTOTYPE:-	Cathode Ray Tube Magnetic Electrostatic Glass, internally coated with conductive coating. GG.4 VCRX 387			Marking See K1001/4 Base B8-0. BS.448 Connections			
Heater Current Max. First Anode Voltage Max. Third Anode Voltage TYPICAL OPERATING CONDITIONS Third Anode Voltage Second Anode Voltage First Anode Voltage Working Beam Current (Peak) (A) (A) (A) (A) (A) (A)		4.0 1.0 1.45 8.0 5.0 850 1.25 250 500	Note	Pin 1 2 3 4 5 6 7 8 Side Contact	Electrode Internal Connection a1 a2 Internal Connection g k h h h		
			A	Side Contact BS.448. CT.7 Dimensions See Drawing Page 4			

NOTES

A. The first anode must always be at least 50V. positive to the second anode and the supply network must take account of variations in first anode current from zero to working value.

TESTS To be performed in addition to those applicable in K1001

au se	Most Conditions	Ma - 4 -	Limits		No.					
Cle	Test Conditions	Tests	Min.	Max.	Tested					
а	See K1001/5A/13	Capacitances (pf) Grid to all other electrodes		25	2%(5)					
	For all tests below Vh = 4.0 Volts									
ъ		Heater Current (A)	0.7	1.2	100%					
	For all tests below Va1 = 1.25 kV; Va3 = 5.0 kV									
С	Adjust Va2 for optimum focus and Vg for cut-off. See K1001/5A.10.	Grid Base -Vg. (V)	40	80	100%					
đ	With a raster scan of convenient size adjust Va2 for optimum focus and Vg for a light intensity of 1.0 candela.	Light Intensity and Grid Drive 1. Change in Vg from that in test "c" (V) 2. The beam current shall increase continuously from zero to that required for 1.0 candela.	-	35	100% 100%					
e	Adjust Va2 for optimum focus at the centre of a linear scan in two directions at right angles successively and a scan length of 135 mm and 100 us duration. Grid drive from cut-off with a 100 us pulse at 100 p.p.s. repetition and amplitude found in test "d1".	1. Line width measured at the centre of the trace (mm) 2. Va2 (V)	700	0.7	100%					
f	(i) Vg = -80 Volts OR (ii) See K1001/5A.3.2. Resistor 5 megohm	Grid Insulation (i) Leakage current (uA) OR (ii) Increase in voltmeter reading. (%)	-	16	100%					
g	Adjust Va2 for optimum focus and Vg any convenient value. No deflecting field.	Deviation of spot from the geometric centre of the screen. (mm)	_	10	100%					
h	With deflection to cover the useful screen dia. using deflection coils positioned as shown in drawing Page 4, adjust Va2 for optimum focus with Vg as in test "d".	Useful Screen Area Diameter on the geometric centre of the screen (mm)	135	-	100%					

u se	Test Conditions	Tests	Limits		No.
Clause	Test Conditions	rests	Min.	Max.	Tested
j	Defocussed raster of any convenient brightness to cover the useful screen area. See note 1.	Blemishes. (Stones, Bubbles and screen defects). Above 1.0 mm. dia. 1.0 mm. to 0.5 mm. dia. Below 0.5 mm. dia. ignore Spacing between blemishes (mm)	No 15	n e	100%

NOTES

1. If two or more blemishes including those below 0.5 mm. are separated by a distance not greater than the maximum dimension of the largest blemish in the group, then the group of blemishes shall be considered as one blemish of dimension equal to the maximum overall dimension of the group.

